74HC4020; 74HCT4020 14-stage binary ripple counter Rev. 6 — 3 February 2016

Product data sheet

General description

The 74HT4020; 74HCT4020 is a 14-stage binary ripple counter with a clock input (CP), an overriding asynchronous master reset input (MR) and 12 buffered parallel outputs (Q0, and Q3 to Q13). The counter advances on the HIGH-to-LOW transition of CP. A HIGH on MR clears all counter stages and forces all outputs LOW, independent of the state of CP. Each counter stage is a static toggle flip-flop. This device features reduced input threshold levels to allow interfacing to TTL logic levels. Inputs also include clamp diodes, this enables the use of current limiting resistors to interface inputs to voltages in excess of V_{CC} .

2. **Features and benefits**

- Wide supply voltage range from 2.0 V to 6.0 V
- Input levels:
 - ◆ For 74HC4020: CMOS level
 - For 74HCT4020: TTL level
- Multiple package options
- Complies with JEDEC standard no. 7A
- Specified from -40 °C to +85 °C and from -40 °C to +125 °C

Applications

- Frequency dividing circuits
- Time delay circuits
- Control counters

Ordering information

Table 1. **Ordering information**

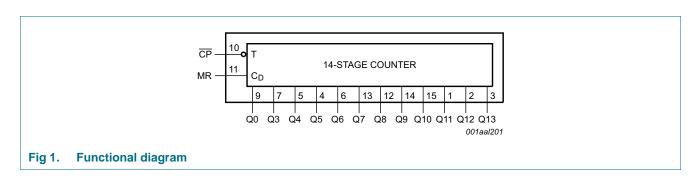
Type number Package										
	Temperature range	Name	Description	Version						
74HC4020D	-40 °C to +125 °C	SO16	plastic small outline package; 16 leads;	SOT109-1						
74HCT4020D			body width 3.9 mm							
74HC4020DB	–40 °C to +125 °C	SSOP16	plastic shrink small outline package; 16 leads; body	SOT338-1						
74HCT4020DB			width 5.3 mm							

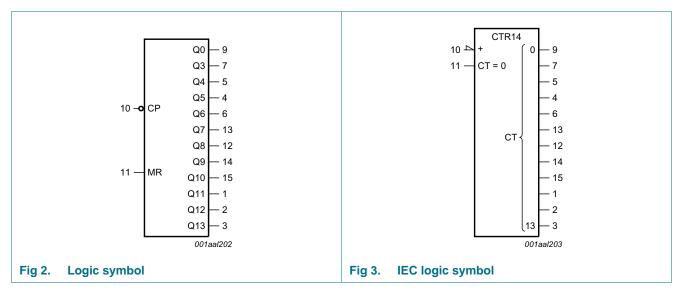


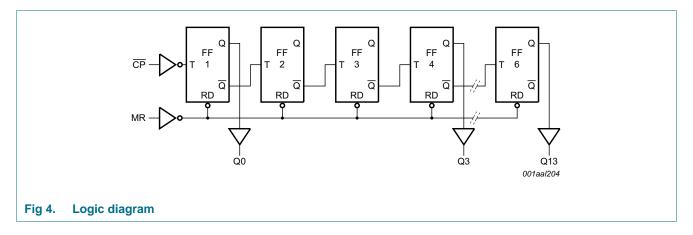
 Table 1.
 Ordering information ...continued

Type number	Package										
	Temperature range	Name	Version								
74HC4020PW	–40 °C to +125 °C	TSSOP16	plastic thin shrink small outline package; 16 leads;	SOT403-1							
74HCT4020PW			body width 4.4 mm								
74HC4020BQ	–40 °C to +125 °C	DHVQFN16		SOT763-1							
74HCT4020BQ			very thin quad flat package; no leads; 16 terminals; body $2.5 \times 3.5 \times 0.85$ mm								

5. Functional diagram

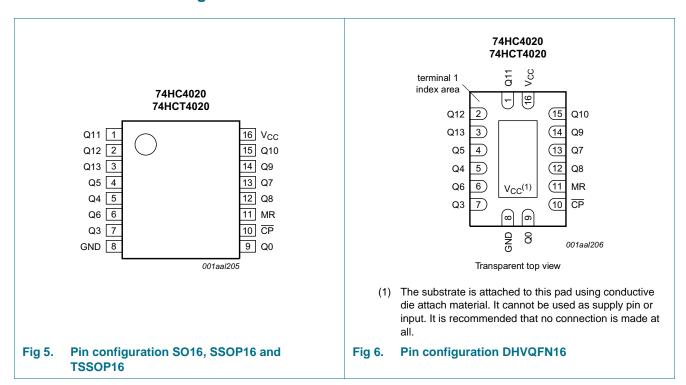






6. Pinning information

6.1 Pinning



6.2 Pin description

Table 2. Pin description

Symbol	Pin	Description
Q0, Q3 to Q13	9, 7, 5, 4, 6, 13, 12, 14, 15, 1, 2, 3	output
GND	8	ground (0 V)
CP	10	clock input (HIGH-to-LOW, edge-triggered)
MR	11	master reset input (active HIGH)
V _{CC}	16	positive supply voltage

74HC HCT4020

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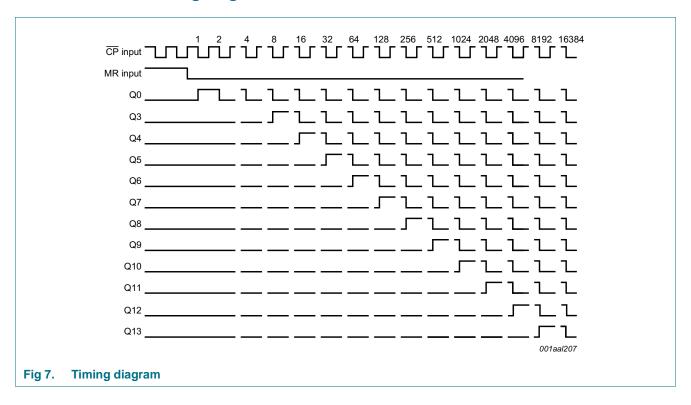
7. Functional description

Table 3. Function table

Input	Output		
CP	MR	Q0, Q3 to Q13	
\uparrow	L	no change	
↓	L	count	
X	Н	L	

[1] H = HIGH voltage level; L = LOW voltage level; X = don't care; ↑ = LOW-to-HIGH clock transition; ↓ = HIGH-to-LOW clock transition.

7.1 Timing diagram



8. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions		Min	Max	Unit
V _{CC}	supply voltage			-0.5	+7	V
I _{IK}	input clamping current	$V_{I} < -0.5 \text{ V or } V_{I} > V_{CC} + 0.5 \text{ V}$		-	±20	mA
I _{OK}	output clamping current	$V_{I} < -0.5 \text{ V or } V_{I} > V_{CC} + 0.5 \text{ V}$		-	±20	mA
Io	output current	$-0.5 \text{ V} < \text{V}_{\text{O}} < \text{V}_{\text{CC}} + 0.5 \text{ V}$		-	±25	mA
I _{CC}	supply current			-	±50	mA
I _{GND}	ground current			-	±50	mA
T _{stg}	storage temperature			-65	+150	°C
P _{tot}	total power dissipation	$T_{amb} = -40 ^{\circ}\text{C} \text{ to } +125 ^{\circ}\text{C}$	[1]			
		SO16, SSOP16, TSSOP16 and DHVQFN16 packages		-	500	mW

^[1] For SO16 package: Ptot derates linearly with 8 mW/K above 70 °C.

For SSOP16 and TSSOP16 packages: P_{tot} derates linearly with 5.5 mW/K above 60 $^{\circ}\text{C}.$

For DHVQFN16 package: P_{tot} derates linearly with 4.5 mW/K above 60 °C.

9. Recommended operating conditions

Table 5. Recommended operating conditions

Symbol	Parameter	Conditions	tions 74HC4020				74HCT4020			
			Min	Тур	Max	Min	Тур	Max		
V _{CC}	supply voltage		2.0	5.0	6.0	4.5	5.0	5.5	V	
VI	input voltage		0	-	V _{CC}	0	-	V _{CC}	V	
Vo	output voltage		0	-	V _{CC}	0	-	V _{CC}	V	
Δt/ΔV	input transition rise and fall rate	except for Schmitt trigger inputs								
		V _{CC} = 2.0 V	-	-	625	-	-	-	ns/V	
		V _{CC} = 4.5 V	-	1.67	139	-	1.67	139	ns/V	
		V _{CC} = 6.0 V	-	-	83	-	-	-	ns/V	
T _{amb}	ambient temperature		-40	+25	+125	-40	+25	+125	°C	

10. Static characteristics

Table 6. Static characteristics

At recommended operating conditions; voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions		25 °C		-40 °C t	o +85 °C	-40 °C to +125 °C		Unit
			Min	Тур	Max	Min	Max	Min	Max	
74HC40	20									
V _{IH}	HIGH-level	V _{CC} = 2.0 V	1.5	1.2	-	1.5	-	1.5	-	V
	input voltage	V _{CC} = 4.5 V	3.15	2.4	-	3.15	-	3.15	-	V
		V _{CC} = 6.0 V	4.2	3.2	-	4.2	-	4.2	-	V
V _{IL}	LOW-level	V _{CC} = 2.0 V	-	0.8	0.5	-	0.5	-	0.5	V
	input voltage	V _{CC} = 4.5 V	-	2.1	1.35	-	1.35	-	1.35	V
		$V_{CC} = 6.0 \text{ V}$	-	2.8	1.8	-	1.8	-	1.8	V
V _{OH}	HIGH-level	$V_I = V_{IH}$ or V_{IL}								
	output voltage	$I_{O} = -20 \mu A; V_{CC} = 2.0 V$	1.9	2.0	-	1.9	-	1.9	-	V
		$I_O = -20 \mu A$; $V_{CC} = 4.5 \text{ V}$	4.4	4.5	-	4.4	-	4.4	-	V
		$I_{O} = -20 \mu A$; $V_{CC} = 6.0 \text{ V}$	5.9	6.0	-	5.9	-	5.9	-	V
		$I_{O} = -4.0 \text{ mA}; V_{CC} = 4.5 \text{ V}$	3.98	4.32	-	3.84	-	3.7	-	V
		$I_{O} = -5.2 \text{ mA}; V_{CC} = 6.0 \text{ V}$	5.48	5.81	-	5.34	-	5.2	-	V
V _{OL}	LOW-level	$V_I = V_{IH}$ or V_{IL}								
	output voltage	$I_O = 20 \mu A; V_{CC} = 2.0 \text{ V}$	-	0	0.1	-	0.1	-	0.1	V
		$I_O = 20 \mu A$; $V_{CC} = 4.5 \text{ V}$	-	0	0.1	-	0.1	-	0.1	V
		$I_O = 20 \mu A; V_{CC} = 6.0 \text{ V}$	-	0	0.1	-	0.1	-	0.1	V
		$I_O = 4.0 \text{ mA}; V_{CC} = 4.5 \text{ V}$	-	0.15	0.26	-	0.33	-	0.4	٧
		$I_O = 5.2 \text{ mA}; V_{CC} = 6.0 \text{ V}$	-	0.16	0.26	-	0.33	-	0.4	٧
l _l	input leakage current	$V_1 = V_{CC}$ or GND; $V_{CC} = 6.0 \text{ V}$	-	-	±0.1	-	±1	-	±1	μΑ
I _{CC}	supply current	$V_I = V_{CC}$ or GND; $I_O = 0$ A; $V_{CC} = 6.0 \text{ V}$	-	-	8.0	-	80	-	160	μΑ
Cı	input capacitance		-	3.5	-	-	-	-	-	pF
74HCT4	020							1		
V_{IH}	HIGH-level input voltage	V _{CC} = 4.5 V to 5.5 V	2.0	1.6	-	2.0	-	2.0	-	V
V_{IL}	LOW-level input voltage	V _{CC} = 4.5 V to 5.5 V	-	1.2	0.8	-	0.8	-	0.8	V
V _{OH}	HIGH-level	$V_I = V_{IH}$ or V_{IL} ; $V_{CC} = 4.5 \text{ V}$								
	output voltage	$I_{O} = -20 \mu A$	4.4	4.5	-	4.4	-	4.4	-	V
		$I_{O} = -4.0 \text{ mA}$	3.98	4.32	-	3.84	-	3.7	-	٧
V _{OL}	LOW-level	$V_I = V_{IH}$ or V_{IL} ; $V_{CC} = 4.5 \text{ V}$								
	output voltage	$I_O = 20 \mu A; V_{CC} = 4.5 V$	-	0	0.1	-	0.1	-	0.1	V
		$I_{O} = 4.0 \text{ mA}; V_{CC} = 4.5 \text{ V}$	-	0.15	0.26	-	0.33	-	0.4	V
I _I	input leakage current	$V_I = V_{CC}$ or GND; $V_{CC} = 5.5 \text{ V}$	-	-	±0.1	-	±1	-	±1	μΑ

Table 6. Static characteristics ... continued

At recommended operating conditions; voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	25 °C		–40 °C to	+85 °C	–40 °C to	Unit		
			Min	Тур	Max	Min	Max	Min	Max	
I _{CC}	supply current	$V_I = V_{CC}$ or GND; $I_O = 0$ A; $V_{CC} = 5.5 \text{ V}$	-	-	8.0	-	80	-	160	μА
ΔI_{CC}	additional supply current	$V_I = V_{CC} - 2.1 \text{ V}; I_O = 0 \text{ A};$ other inputs at V_{CC} or GND; $V_{CC} = 4.5 \text{ V}$ to 5.5 V								
		pin MR	-	110	396	-	495	-	539	μΑ
		pin CP	-	85	306	-	383	-	417	μΑ
Cı	input capacitance		-	3.5	-	-	-	-	-	pF

11. Dynamic characteristics

Table 7. Dynamic characteristics

GND (ground = 0 V); $C_L = 50$ pF unless otherwise specified; for test circuit, see Figure 10

Symbol	Parameter	Conditions		25 °C		-40 °C t	o +85 °C	-40 °C to	+125 °C	Unit
			Min	Тур	Max	Min	Max	Min	Max	
74HC402	20									
t _{pd}	propagation	CP to Q0; see Figure 8								
	delay	$V_{CC} = 2.0 \text{ V}; C_L = 50 \text{ pF}$	-	39	140	-	175	-	210	ns
		$V_{CC} = 4.5 \text{ V}; C_L = 50 \text{ pF}$	-	14	28	-	35	-	42	ns
		$V_{CC} = 5.0 \text{ V}; C_L = 15 \text{ pF}$	-	11	-	-	-	-	-	ns
		V _{CC} = 6.0 V; C _L = 50 pF	-	11	24	-	30	-	36	ns
		Qn to Qn+1; see Figure 9								
		$V_{CC} = 2.0 \text{ V}; C_L = 50 \text{ pF}$	-	22	75	-	95	-	110	ns
		$V_{CC} = 4.5 \text{ V}; C_L = 50 \text{ pF}$	-	8	15	-	19	-	22	ns
		V _{CC} = 5.0 V; C _L = 15 pF	-	6	-	-	-	-	-	ns
		V _{CC} = 6.0 V; C _L = 50 pF	-	6	13	-	16	-	19	ns
t _{PHL}	HIGH to LOW	MR to Qn; see Figure 8								
	propagation	$V_{CC} = 2.0 \text{ V}; C_L = 50 \text{ pF}$	-	55	170	-	215	-	225	ns
	delay	$V_{CC} = 4.5 \text{ V}; C_L = 50 \text{ pF}$	-	20	34	-	43	-	51	ns
		$V_{CC} = 5.0 \text{ V}; C_L = 15 \text{ pF}$	-	17	-	-	-	-	-	ns
		$V_{CC} = 6.0 \text{ V}; C_L = 50 \text{ pF}$	-	16	29	-	37	-	43	ns
t _t	transition	Qn; see Figure 8 [2]								
	time	$V_{CC} = 2.0 \text{ V}; C_L = 50 \text{ pF}$	-	19	75	-	95	-	110	ns
		V _{CC} = 4.5 V; C _L = 50 pF	-	7	15	-	19	-	22	ns
		$V_{CC} = 6.0 \text{ V}; C_L = 50 \text{ pF}$	-	6	13	-	16	-	19	ns

Table 7. **Dynamic characteristics** ...continued

GND (ground = 0 V): C_{i} = 50 pF unless otherwise specified; for test circuit, see Figure 10.

Symbol	Parameter	Conditions			25 °C		-40 °C t	o +85 °C	-40 °C t	o +125 °C	Unit
				Min	Тур	Max	Min	Max	Min	Max	
t _W	pulse width	CP HIGH or LOW;									
		see Figure 8									
		$V_{CC} = 2.0 \text{ V}; C_L = 50 \text{ pF}$		80	14	-	100	-	120	-	ns
		$V_{CC} = 4.5 \text{ V}; C_L = 50 \text{ pF}$		16	4	-	20	-	24	-	ns
		$V_{CC} = 6.0 \text{ V}; C_L = 50 \text{ pF}$		14	3	-	17	-	20	-	ns
		MR HIGH; see Figure 8									
		$V_{CC} = 2.0 \text{ V}; C_L = 50 \text{ pF}$		80	17	-	100	-	120	-	ns
		$V_{CC} = 4.5 \text{ V}; C_L = 50 \text{ pF}$		16	6	-	20	-	24	-	ns
		$V_{CC} = 6.0 \text{ V}; C_L = 50 \text{ pF}$		14	5	-	17	-	20	-	ns
t _{rec}	recovery time	MR to CP; see Figure 8									
		$V_{CC} = 2.0 \text{ V}; C_L = 50 \text{ pF}$		50	6	-	65	-	75	-	ns
		$V_{CC} = 4.5 \text{ V}; C_L = 50 \text{ pF}$		10	2	-	13	-	15	-	ns
		$V_{CC} = 6.0 \text{ V}; C_L = 50 \text{ pF}$		9	2	-	11	-	13	-	ns
f _{max}	maximum	see Figure 8									
	frequency	$V_{CC} = 2.0 \text{ V}; C_L = 50 \text{ pF}$		6.0	30	-	4.8	-	4.0	-	MHz
		$V_{CC} = 4.5 \text{ V}; C_L = 50 \text{ pF}$		30	92	-	24	-	20	-	MHz
		$V_{CC} = 5.0 \text{ V}; C_L = 15 \text{ pF}$		-	101	-	-	-	-	-	MHz
		$V_{CC} = 6.0 \text{ V}; C_L = 50 \text{ pF}$		35	109	-	28	-	24	-	MHz
C_{PD}	power dissipation capacitance		[3]	-	19	-	-	-	-	-	pF
74HCT40	020										-
t _{pd}	propagation	CP to Q0; see Figure 8	[1]								
	delay	$V_{CC} = 4.5 \text{ V}; C_L = 50 \text{ pF}$		-	18	36	-	45	-	54	ns
		$V_{CC} = 5.0 \text{ V}; C_L = 15 \text{ pF}$		-	15	-	-	-	-	-	ns
		Qn to Qn+1; see Figure 9									
		$V_{CC} = 4.5 \text{ V}; C_L = 50 \text{ pF}$		_	8	15	-	19	-	22	ns
		$V_{CC} = 5.0 \text{ V}; C_L = 15 \text{ pF}$		_	6	-	-	-	-	-	ns
t _{PHL}	HIGH to LOW	MR to Qn; see Figure 8									
	propagation	$V_{CC} = 4.5 \text{ V}; C_{L} = 50 \text{ pF}$		_	22	45	-	56	-	68	ns
	delay	$V_{CC} = 5.0 \text{ V}; C_L = 15 \text{ pF}$		_	19	-	-	-	-	-	ns
t _t	transition	Qn; see Figure 8	[2]								
	time	$V_{CC} = 4.5 \text{ V}; C_L = 50 \text{ pF}$		-	7	15	-	19	-	22	ns
t _W	pulse width	CP HIGH or LOW; see Figure 8									
		$V_{CC} = 4.5 \text{ V}; C_L = 50 \text{ pF}$		20	7	-	25	-	30	-	ns
		MR HIGH; see Figure 8									
		$V_{CC} = 4.5 \text{ V}; C_L = 50 \text{ pF}$		20	8	-	25	-	30	-	ns
t _{rec}	recovery time	MR to CP; see Figure 8			-		_		2.2		-
100	222.2.70	$V_{CC} = 4.5 \text{ V; } C_L = 50 \text{ pF}$		10	2	_	13	-	15		ns

Dynamic characteristics ...continued Table 7.

GND (ground = 0 V); $C_L = 50$ pF unless otherwise specified; for test circuit, see Figure 10

Symbol	Parameter	Conditions	25 °C		-40 °C to	o +85 °C	–40 °C to	Unit		
			Min	Тур	Max	Min	Max	Min	Max	
f_{max}	maximum	see Figure 8								
	frequency	$V_{CC} = 4.5 \text{ V}; C_L = 50 \text{ pF}$	25	47	-	20	-	17	-	MHz
		V _{CC} = 5.0 V; C _L = 15 pF	-	52	-	-	-	-	-	MHz
C _{PD}	power dissipation capacitance	[3]	-	20	-	-	-	-	-	pF

- [1] t_{pd} is the same as t_{PHL} and t_{PLH} .
- [2] t_t is the same as t_{THL} and t_{TLH} .
- [3] C_{PD} is used to determine the dynamic power dissipation (P_D in μW).

 $P_D = C_{PD} \times V_{CC}^2 \times f_i + \Sigma (C_L \times V_{CC}^2 \times f_o) \text{ where:}$

 f_i = input frequency in MHz;

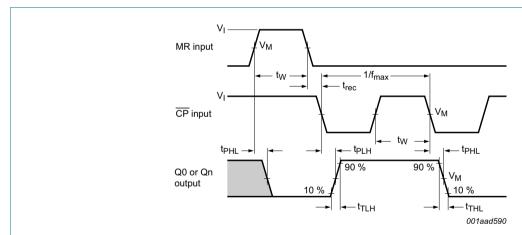
f_o = output frequency in MHz;

 $\Sigma (C_L \times V_{CC}^2 \times f_0) = \text{sum of outputs};$

C_L = output load capacitance in pF;

V_{CC} = supply voltage in V.

12. Waveforms



Measurement points are given in Table 8.

V_{OL} and V_{OH} are typical voltage output levels that occur with the output load.

Clock timing, propagation delays, pulse widths and measurement points Fig 8.

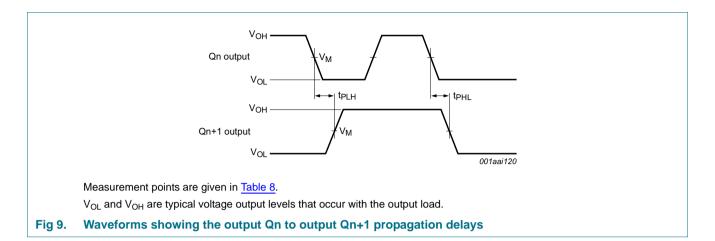
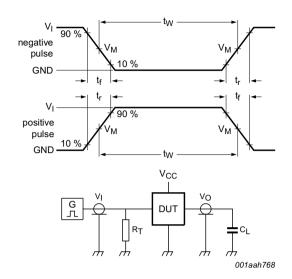


Table 8. Measurement points

Туре	Input	Output
	V _M	V _M
74HC4020	$0.5 \times V_{CC}$	$0.5 \times V_{CC}$
74HCT4020	1.3 V	1.3 V



Test data is given in Table 9.

Definitions test circuit:

 R_T = Termination resistance should be equal to output impedance Z_0 of the pulse generator.

 C_L = Load capacitance including jig and probe capacitance.

Fig 10. Test circuit for measuring switching times

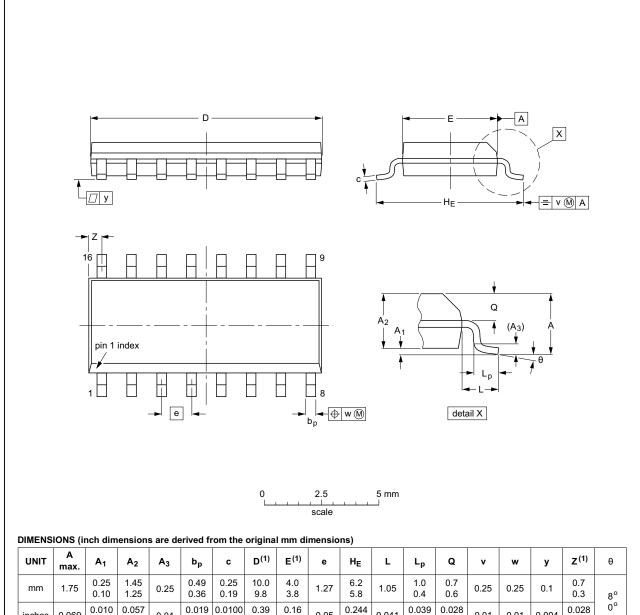
Table 9. Test data

Туре	Input	Load	
	VI	t _r , t _f	CL
74HC4020	V _{CC}	6 ns	15 pF, 50 pF
74HCT4020	3 V	6 ns	15 pF, 50 pF

13. Package outline

SO16: plastic small outline package; 16 leads; body width 3.9 mm

SOT109-1



UNIT	max.	A ₁	A ₂	A ₃	b _p	С	D ⁽¹⁾	E ⁽¹⁾	е	HE	L	Lp	Q	v	w	У	Z ⁽¹⁾	θ
mm	1.75	0.25 0.10	1.45 1.25	0.25	0.49 0.36	0.25 0.19	10.0 9.8	4.0 3.8	1.27	6.2 5.8	1.05	1.0 0.4	0.7 0.6	0.25	0.25	0.1	0.7 0.3	8°
inches	0.069	0.010 0.004	0.057 0.049	0.01	0.019 0.014	0.0100 0.0075	0.39 0.38	0.16 0.15	0.05	0.244 0.228	0.041	0.039 0.016	0.028 0.020	0.01	0.01	0.004	0.028 0.012	0°

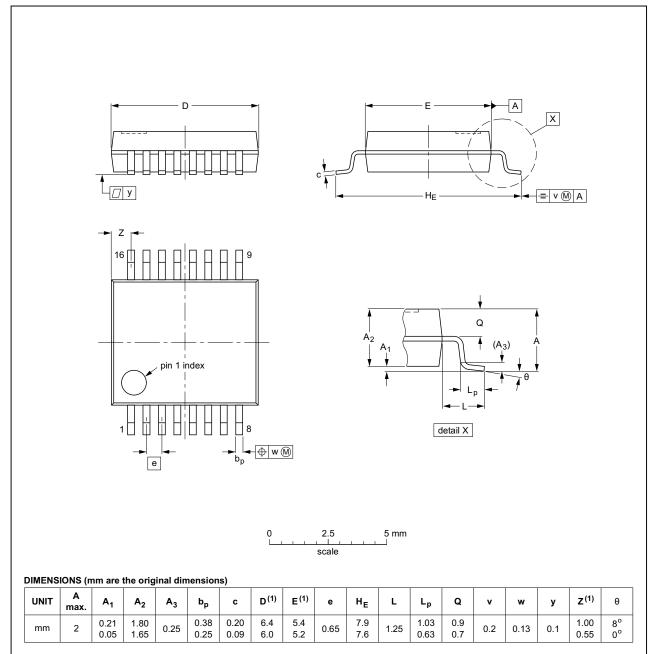
1. Plastic or metal protrusions of 0.15 mm (0.006 inch) maximum per side are not included.

OUTLINE		REFER	EUROPEAN	ISSUE DATE			
VERSION	IEC	JEDEC	JEITA		PROJECTION	ISSUE DATE	
SOT109-1	076E07	MS-012				99-12-27 03-02-19	

Fig 11. Package outline SOT109-1 (SO16)

SSOP16: plastic shrink small outline package; 16 leads; body width 5.3 mm

SOT338-1



Note

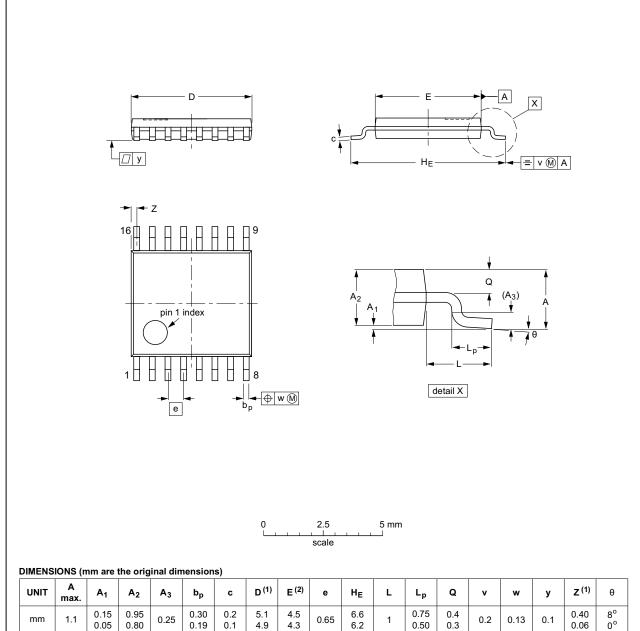
1. Plastic or metal protrusions of 0.25 mm maximum per side are not included.

OUTLINE		REFER	RENCES	EUROPEAN	ISSUE DATE
VERSION	IEC	JEDEC	JEITA	PROJECTION	ISSUE DATE
SOT338-1		MO-150			99-12-27 03-02-19

Fig 12. Package outline SOT338-1 (SSOP16)

TSSOP16: plastic thin shrink small outline package; 16 leads; body width 4.4 mm

SOT403-1



UNIT	A max.	A ₁	A ₂	A ₃	bp	С	D ⁽¹⁾	E (2)	е	HE	L	Lp	Q	>	w	у	Z ⁽¹⁾	θ
mm	1.1	0.15 0.05	0.95 0.80	0.25	0.30 0.19	0.2 0.1	5.1 4.9	4.5 4.3	0.65	6.6 6.2	1	0.75 0.50	0.4 0.3	0.2	0.13	0.1	0.40 0.06	8° 0°

Notes

- 1. Plastic or metal protrusions of 0.15 mm maximum per side are not included.
- 2. Plastic interlead protrusions of 0.25 mm maximum per side are not included.

OUTLINE		REFER	RENCES	EUROPEAN	ISSUE DATE
VERSION	IEC	JEDEC	JEITA	PROJECTION	ISSUE DATE
SOT403-1		MO-153			99-12-27 03-02-18

Fig 13. Package outline SOT403-1 (TSSOP16)

DHVQFN16: plastic dual in-line compatible thermal enhanced very thin quad flat package; no leads; 16 terminals; body 2.5 x 3.5 x 0.85 mm SOT763-1

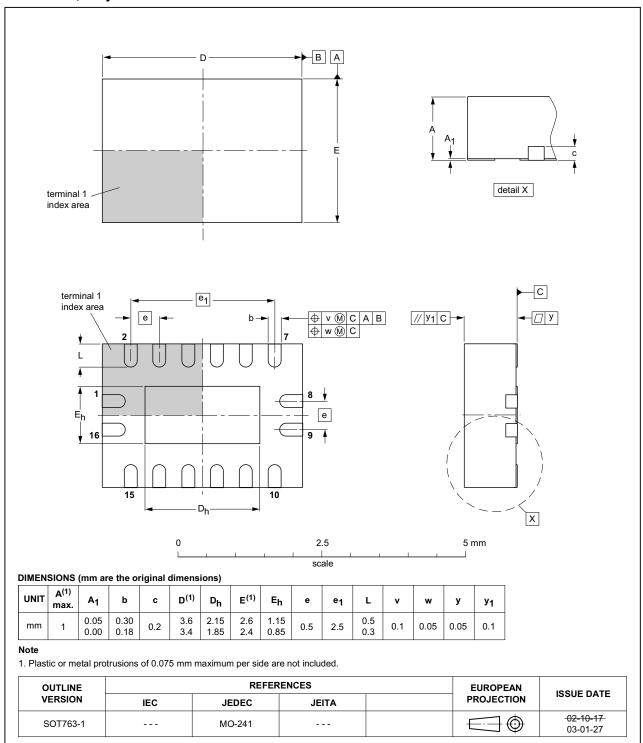


Fig 14. Package outline SOT763-1 (DHVQFN16)

14. Abbreviations

Table 10. Abbreviations

Acronym	Abbreviation
CMOS	Complementary Metal Oxide Semiconductor
DUT	Device Under Test

15. Revision history

Table 11. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
74HC_HCT4020 v.6	20160203	Product data sheet	-	74HC_HCT4020 v.5
Modifications:	Type numbers 74H0	C4020N and 74HCT4020	N (SOT38-4) remo	oved.
74HC_HCT4020 v.5	20120806	Product data sheet	-	74HC_HCT4020 v.4
Modifications:	Measurement points	added to figure 8 (errata	a).	
74HC_HCT4020 v.4	20111213	Product data sheet	-	74HC_HCT4020 v.3
Modifications:	 Legal pages update 	d.		
74HC_HCT4020 v.3	20100120	Product data sheet	-	74HC_HCT4020_CNV v.2
74HC_HCT4020_CNV v.2	19970901	Product specification	-	-

16. Legal information

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Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions".
- [3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL http://www.nxp.com.

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74HC4020; 74HCT4020

14-stage binary ripple counter

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